Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination		
10772518	DYE ET AL.		
Examiner	Art Unit		
Chen, Qing	2191		

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES		
Search Notes	Date	Examiner
Appeal Conference Conducted (Qing Chen, Wei Zhen, and Lewis Bullock, Jr.)	1/4/2010	/QC/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20100104